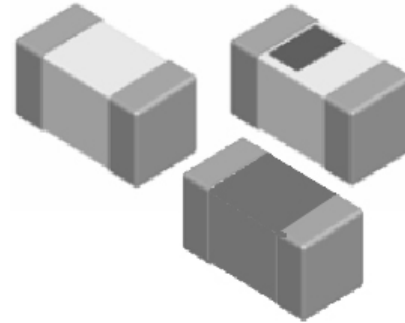


Multilayer Chip Ceramic Inductor



◆ **Features**

- 1、 Monolithic Structure for high reliability
- 2、 High self-resonant frequency
- 3、 Excellent solderability and high heat resistance
- 4、 RoHS Compliant.



◆ **Application**

- 1、 RF Circuit of in telecommunication and other Equipments

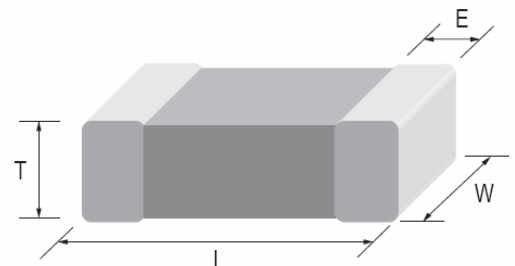
◆ **PRODUCT IDENTIFICATION**

CMCC 1005 C 1N0 S S P
(1) (2) (3) (4) (5) (6) (7)

- (1) Series Type
- (2) Chip Size (mm) :Length X Width
- (3) Material Code
- (4) Inductance: 1N0=1nH; 10N=10nH
R10=100nH
- (5) Inductance Tolerance: S=±0.3;
J=±5%; K=±10%
- (6) Company Code
- (7) Packaging:P–Embossed paper tape, 7" reel
E- Embossed plastic tape, 7" reel

◆ **Dimensions Unit: mm**

Size(EIA)	L	W	T	E
	1.00±0.10	0.50±0.10	0.50±0.10	0.25±0.10



◆ Specifications

Part Number	Inductance (nH)	Min. Quality Factor (Q)	L, Q Test Freq. L/Q(MHz)	Typical Q @ Freq. (MHz)						Min. Self-resonant Frequency (MHz)	Max. DC Resistance (Ω)	Max. Rated Current (mA)
				100	300	500	800	1000	1800			
				Q								
CMCC1005 Series												
CMCC1005C0N6SSP	0.6±0.3	4	100	6	21	30	35	41	52	10000	0.10	800
CMCC1005C1N0SSP	1.0±0.3	8	100	11	21	25	33	35	52	10000	0.10	400
CMCC1005C1N1SSP	1.1±0.3	8	100	11	21	25	33	35	52	10000	0.10	400
CMCC1005C1N2SSP	1.2±0.3	8	100	11	21	25	33	35	52	10000	0.10	400
CMCC1005C1N3SSP	1.3±0.3	8	100	11	21	25	33	35	52	10000	0.12	400
CMCC1005C1N5SSP	1.5±0.3	8	100	11	21	25	33	35	52	6000	0.13	400
CMCC1005C1N8SSP	1.8±0.3	8	100	10	18	21	29	32	49	6000	0.14	400
CMCC1005C2N0SSP	2.0±0.3	8	100	10	17	21	28	32	47	6000	0.15	400
CMCC1005C2N2SSP	2.2±0.3	8	100	10	17	21	28	31	47	6000	0.16	400
CMCC1005C2N4SSP	2.4±0.3	8	100	10	17	21	28	31	46	5500	0.16	400
CMCC1005C2N7SSP	2.7±0.3	8	100	10	17	21	28	31	46	5500	0.17	400
CMCC1005C3N0SSP	3.0±0.3	8	100	10	17	21	28	31	46	5500	0.18	400
CMCC1005C3N3SSP	3.3±0.3	8	100	10	17	21	28	31	46	5500	0.19	400
CMCC1005C3N6SSP	3.6±0.3	8	100	10	17	21	28	31	45	5200	0.22	400
CMCC1005C3N9SSP	3.9±0.3	8	100	10	17	21	28	31	45	5200	0.22	400
CMCC1005C4N3SSP	4.3±0.3	8	100	10	17	21	28	31	45	4800	0.24	400
CMCC1005C4N7SSP	4.7±0.3	8	100	10	17	21	28	31	45	4800	0.24	400
CMCC1005C5N1SSP	5.1±0.3	8	100	10	17	21	25	29	44	4600	0.26	400
CMCC1005C5N6SSP	5.6±0.3	8	100	10	17	21	25	29	44	4600	0.27	400
CMCC1005C6N2SSP	6.2±0.3	8	100	10	17	21	25	29	44	4200	0.30	300
CMCC1005C6N8JSP	6.8	8	100	10	18	21	26	30	44	4000	0.32	300
CMCC1005C7N5JSP	7.5	8	100	10	18	21	26	30	43	3600	0.37	300
CMCC1005C8N2JSP	8.2	8	100	10	18	21	26	30	43	3600	0.37	300
CMCC1005C9N1JSP	9.1	8	100	10	18	21	26	30	42	3200	0.40	300
CMCC1005C10NJSP	10	8	100	10	18	21	26	30	42	3200	0.40	300
CMCC1005C12NJSP	12	8	100	10	17	21	24	27	33	2800	0.50	300

◆ Specifications

Part Number	Inductance (nH)	Min. Quality Factor (Q)	L, Q Test Freq. L/Q(MHz)	Typical Q @ Freq. (MHz)						Min. Self-resonant Frequency (MHz)	Max. DC Resistance (Ω)	Max. Rated Current (mA)
				100	300	500	800	1000	1800			
				Q								
CMCC1005 Series												
CMCC1005C15NJSP	15	8	100	10	17	20	23	26	27	2500	0.50	300
CMCC1005C18NJSP	18	8	100	10	17	20	21	23	9	2200	0.60	300
CMCC1005C22NJSP	22	8	100	10	18	21	22	23	-	2000	0.60	300
CMCC1005C27NJSP	27	8	100	10	18	20	21	22	-	1600	0.70	300
CMCC1005C33NJSP	33	8	100	10	18	20	21	21	-	1300	0.80	200
CMCC1005C39NJSP	39	8	100	10	18	19	20	17	-	1200	1.00	150
CMCC1005C47NJSP	47	8	100	10	18	19	18	-	-	1000	1.10	150
CMCC1005C56NJSP	56	8	100	10	18	19	13	-	-	900	1.20	150
CMCC1005C68NJSP	68	8	100	10	18	19	13	-	-	800	1.40	150
CMCC1005C82NJSP	82	8	100	10	18	19	13	-	-	750	2.40	150
CMCC1005CR10JSP	100	8	100	10	18	19	12	-	-	700	2.60	150
CMCC1005CR12JSP	120	8	100	10	18	19	-	-	-	600	2.80	150
CMCC1005CR15JSP	150	8	100	10	17	8	-	-	-	550	3.20	100
CMCC1005CR18JSP	180	8	100	10	17	-	-	-	-	500	3.70	100
CMCC1005CR22JSP	220	8	100	12	14	-	-	-	-	450	4.00	100
CMCC1005CR27JSP	270	8	100	12	12	-	-	-	-	400	4.50	100
CMCC1005CR30JSP	300	5	50	12	-	-	-	-	-	350	7.00	50
CMCC1005CR33JSP	330	5	50	8	-	-	-	-	-	350	7.00	50
CMCC1005CR36JSP	360	5	50	12	-	-	-	-	-	300	7.50	50

◆ General Technical Data

Operating Temperature Range	-55°C ~ +125°C
Storage Condition	Less than 40°C and 70% RH
Soldering Method	Reflow or Wave Soldering

◆ **Composition / Information on Ingredients**

Product Structure: See Fig.1, Fig. 2 and Fig. 3



Fig.1 Shape

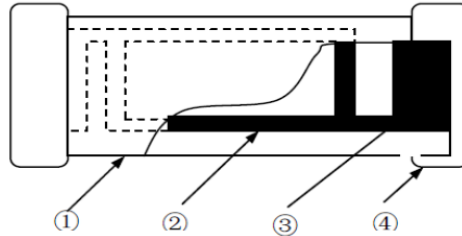


Fig.2 Body Structure

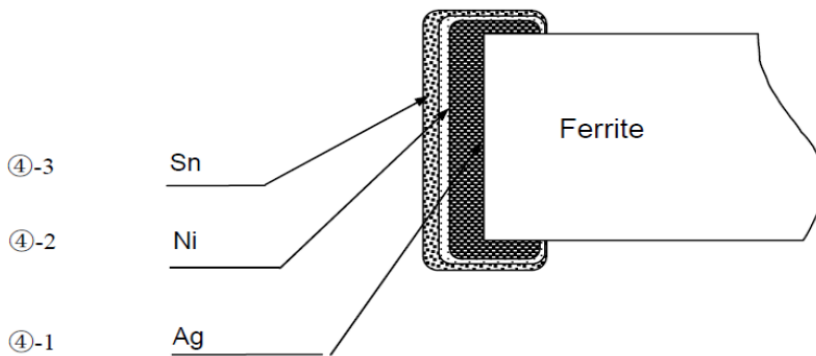


Fig. 3 Structure of Electro-plating

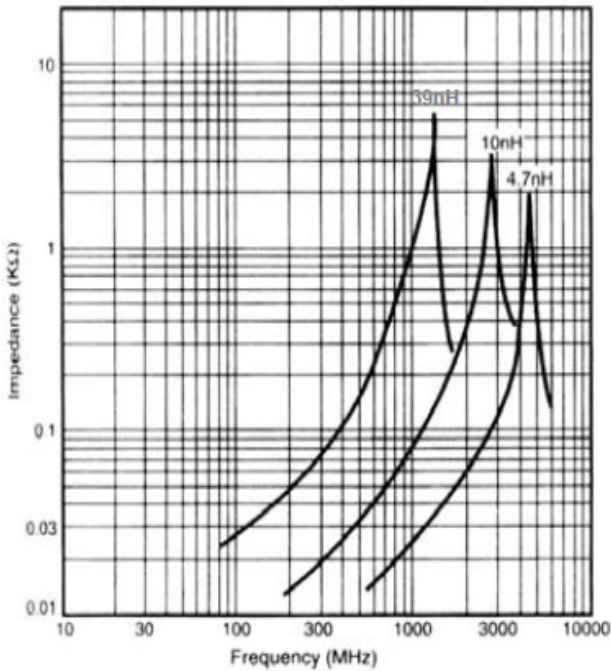
Composition/Information on the Components		
Code	Material	Main Components
①	Ceramic	Boron Silicate, Al ₂ O ₃ , Secret
②	Inner Coil	Silver (Ag)
③	Pull-out Electrode	Silver (Ag)
④-1	Terminal Electrode	Silver (Ag)
④-2	Electrode-plating: Nickel plating	Nickel (Ni)
④-3	Electrode-plating: Sn plating	Tin (Sn)

Compositions Wt Rate (Wt%) of Material		
Material	Wt Rate (Wt%)	CAS No.
Boron Silicate	51~65	65997-18-4
Al ₂ O ₃	14~17	1344-28-1
Secret	0~5	-
Ag	9~29	7440-22-4
Nickel	1.8~2.3	7440-02-0
Tin	3.6~4.7	7440-31-5

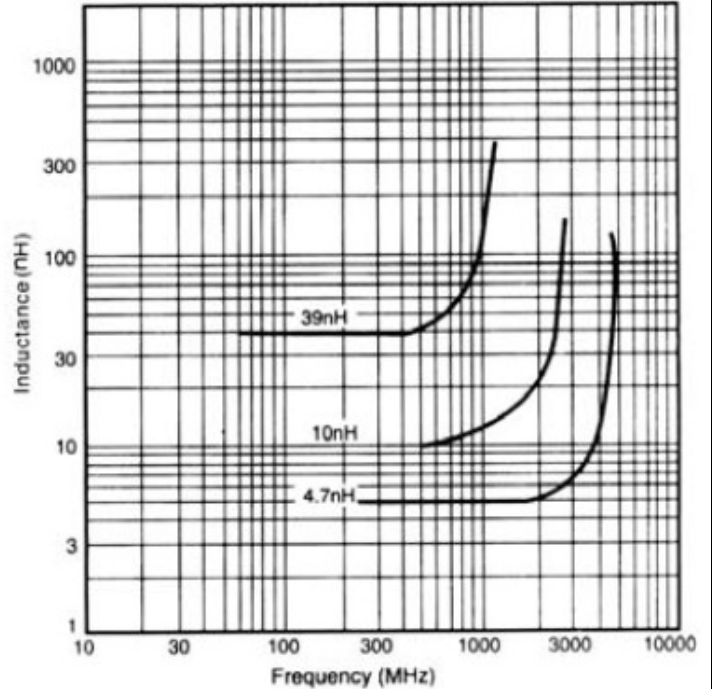
◆ TYPICAL ELECTRICAL CHARACTERISTICS

CMCC1005 Series

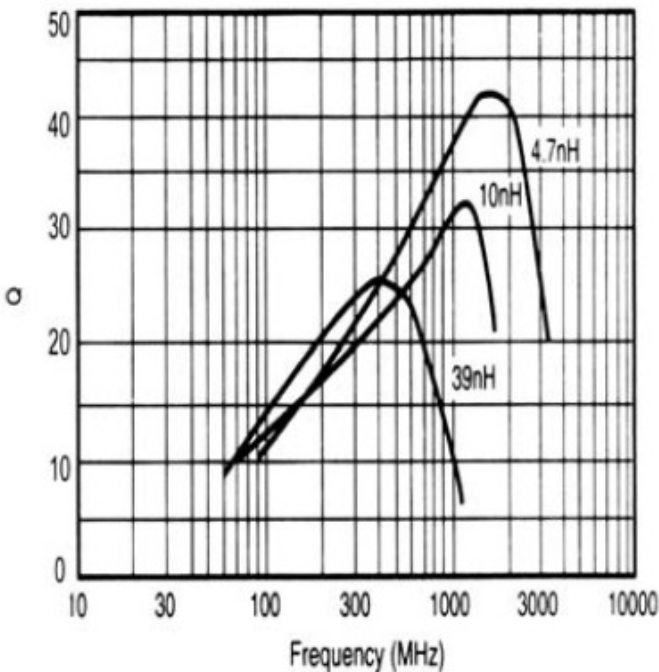
Inductance vs. Frequency Characteristics



Impedance vs. Frequency Characteristics



Q vs. Frequency Characteristics



◆ **Test and Measurement Procedures**

1、 Test Conditions

A、 unless otherwise specified, the standard atmospheric conditions for measurement/test as:

- a.Ambient Temperature: $20\pm 15^{\circ}\text{C}$
- b.Relative Humidity: $65\pm 20\%$
- c.Air Pressure: 86kPa to 106kPa

B、 If any doubt on the results, measurements/tests should be made within the following limits:

- a.Ambient Temperature: $20\pm 2^{\circ}\text{C}$
- b.Relative Humidity: $65\pm 5\%$
- c.Air Pressure: 86kPa to 106kPa

2、 Visual Examination

a .Inspection Equipment: 20× magnifier

3、 Electrical Test

A、 DC Resistance (DCR)

- a.Refer to Appendix A.
- b.Test equipment (Analyzer): High Accuracy Milliohmmeter-HP4338B or equivalent.

B、 Inductance (L)

- a.Refer to Appendix A.
- b.Test equipment: High Accuracy RF Impedance /Material Analyzer-E4991A+HP16192A or equivalent.
- c.Test signal: -20dBm or 50mV
- d.Test frequency refers to Appendix A.

C、 Q Factor (Q)

- a.Refer to Appendix A.
Test equipment: High Accuracy RF Impedance /Material Analyzer-E4991A+HP16192A or equivalent.
- b.Test signal: -20dBm or 50mV
- c.Test frequency refers to Appendix A.

4、 Self-Resonant Frequency (SRF)

- A、 Refer to Appendix A.
Test equipment: High Accuracy RF Impedance /Material Analyzer- E4991A+HP16192A or Agilent E5071C Network analyzer(when $\text{SRF} > 3\text{GHz}$).
- B、 Test signal: -20dBm or 50 mV

5、 Rated Current

- A、 Refer to Appendix A.
- B、 Test equipment (see Fig1): Electric Power, Electric current meter, Thermometer.
- C、 Measurement method (see Fig1):
 - a.Set test current to be 0mA.
 - b.Measure initial temperature of chip surface.
 - c.Gradually increase voltage and measure chip temperature for corresponding current.
- D、 Definition of Rated Current(I_r): I_r is direct electric current as chip surface temperature rose just 20°C against chip initial surface temperature(T_a) (see Fig2).

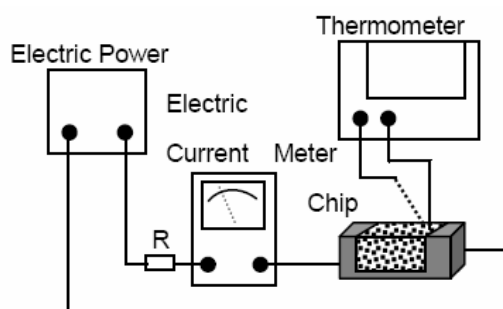


Fig1

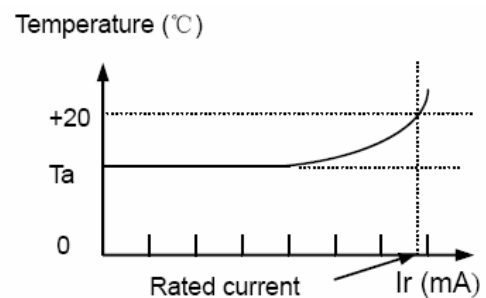
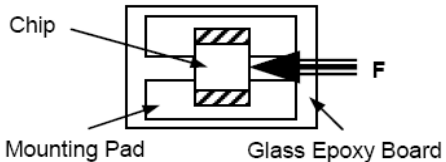
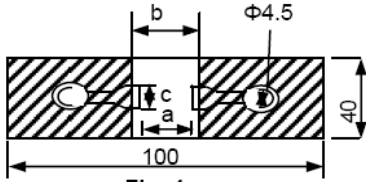
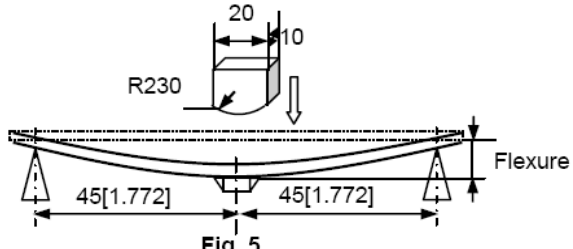
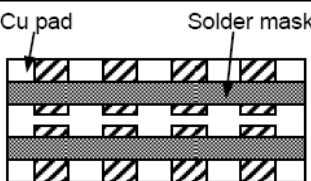
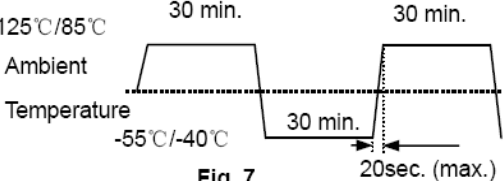


Fig2

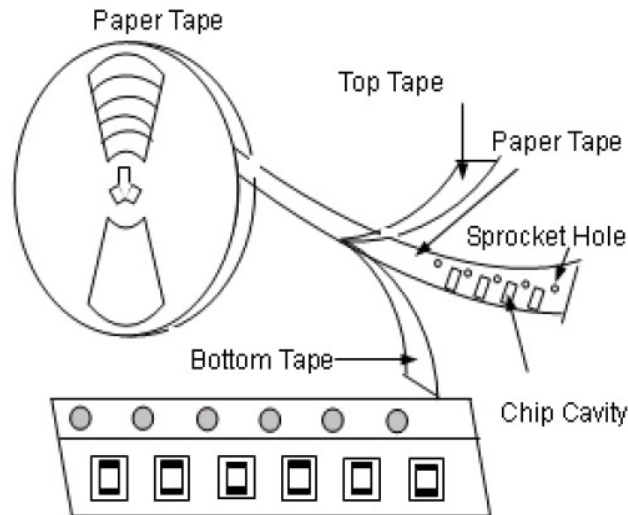
◆ Reliability Test

Items	Requirements	Test Methods and Remarks								
1. Terminal Strength	<p>No removal or split of the termination or other defects shall occur.</p>  <p>Chip Mounting Pad Glass Epoxy Board Fig.3</p>	<ol style="list-style-type: none"> Solder the inductor to the testing jig (glass epoxy board shown in Fig. 3) using leadfree solder. Then apply a force in the direction of the arrow. 5N force for 1005 series. Keep time: 10±1s Speed: 1.0mm/s. 								
2. Resistance to Flexure	<p>No visible mechanical damage.</p> <table border="1" data-bbox="284 712 742 801"> <thead> <tr> <th>Type</th> <th>a</th> <th>b</th> <th>c</th> </tr> </thead> <tbody> <tr> <td>1005[0402]</td> <td>1.0</td> <td>3.0</td> <td>1.2</td> </tr> </tbody> </table> <p>Unit: mm [inch]</p>  <p>Fig. 4</p>	Type	a	b	c	1005[0402]	1.0	3.0	1.2	<ol style="list-style-type: none"> Solder the inductor to the test jig (glass epoxy board shown in Fig. 4) Using a leadfree solder. Then apply a force in the direction shown Fig.5 Flexure: 2mm. Pressurizing Speed: 0.5mm/sec. Keep time: 30 sec.  <p>Fig. 5</p>
Type	a	b	c							
1005[0402]	1.0	3.0	1.2							
3. Vibration	<ol style="list-style-type: none"> No visible mechanical damage. Inductance change: Within ±10%. Q factor change: Within ±20%.  <p>Glass Epoxy Board Fig. 6</p>	<ol style="list-style-type: none"> Solder the inductor to the testing jig (glass epoxy board shown in Fig.6) using leadfree solder. The inductor shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3mutually perpendicular directions (total of 6 hours). 								
4. Dropping	<ol style="list-style-type: none"> No visible mechanical damage. Inductance change: Within ±10%. Q factor change: Within ±20%. 	Drop chip inductor 10 times on a concrete floor from a height of 100 cm.								
5. Temperature	Inductance change should be within ±10% of initial value measuring at 20°C.	Temperature range: -55°C to +125°C, Reference temperature: 20°C								
6. Solderability	<ol style="list-style-type: none"> No visible mechanical damage. Wetting shall exceed 75% coverage for 0603 series; exceed 95% for others 	<ol style="list-style-type: none"> Solder temperture:240±2°C Duration: 3 sec. Solder: Sn/3.0Ag/0.5Cu. Flux: 25% Resin and 75% ethanol in weight. 								
7. Resistance to Soldering Heat	<ol style="list-style-type: none"> No visible mechanical damage. Wetting shall exceed 75% coverage for 0603 series; exceed 95% coverage for others Inductance change: Within ±10%. Q factor change: Within ±20%. 	<ol style="list-style-type: none"> Solder temperature: 260±3°C Duration: 5 sec. Solder: Sn/3.0Ag/0.5Cu. Flux: 25% Resin and 75% ethanol in weight. The chip shall be stabilized at normal condition for 1~2 hours before measuring. 								

<p>8. Thermal Shock</p>	<p>① No mechanical damage. ② Inductance change: Within $\pm 10\%$. ③ Q factor change: Within $\pm 20\%$.</p>  <p>Fig. 7</p>	<p>① Temperature, Time: (See Fi.7) -55°C for 30±3 min→125°C for 30±3min, ② Transforming interval: Max. 20 sec. ③ Tested cycle: 100 cycles. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>
<p>9. Resistance to Low Temperature</p>	<p>① No mechanical damage. ② Inductance change: Within $\pm 10\%$. ③ Q factor change: Within $\pm 20\%$.</p>	<p>① Temperature: -55±2°C, ② Duration: 1000⁺²⁴ hours. ③ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>
<p>10. Resistance to High Temperature</p>	<p>① No mechanical damage. ② Inductance change: Within $\pm 10\%$. ③ Q factor change: Within $\pm 20\%$.</p>	<p>① Temperature: 125±2°C, ② Duration: 1000⁺²⁴ hours. ③ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>
<p>11. Damp Heat (Steady States)</p>	<p>① No visible mechanical damage. ② Inductance change: Within $\pm 10\%$. ③ Q factor change: Within $\pm 20\%$.</p>	<p>① Temperature: 60±2°C ② Humidity: 90% to 95% RH. ③ Duration: 1000⁺²⁴ hours. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>
<p>12. Loading Under Damp Heat</p>	<p>① No visible mechanical damage. ② Inductance change: Within $\pm 10\%$. ③ Q factor change: Within $\pm 20\%$.</p>	<p>① Temperature: 60±2°C ② Humidity: 90% to 95% RH. ③ Duration: 1000⁺²⁴ hours. ④ Applied current: Rated current. ⑤ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>
<p>13. Loading at High Temperature (Life Test)</p>	<p>① No visible mechanical damage. ② Inductance change: Within $\pm 10\%$. ③ Q factor change: Within $\pm 20\%$.</p>	<p>① Temperature: 125±2°C, ② Duration: 1000⁺²⁴ hours. ③ Applied current: Rated current. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>

◆ Packaging

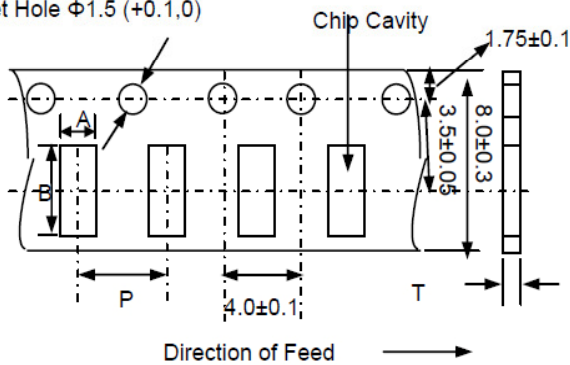
(1) Taping Drawings (Unit: mm)



Remark: The sprocket holes are to the right as the tape is pulled toward the user.

(2) Taping Dimensions (Unit: mm)

Sprocket Hole $\Phi 1.5 (+0.1, 0)$



Paper Tape

Type	A	B	P	T max	Quantity
1005(0402)	0.065±0.1	1.15±0.1	2.0±0.05	0.8	10K

(3) Reel Dimensions (Unit: mm)

